## Notice of References Cited Application/Control No. 10/056,031 Examiner Phuoc H. Nguyen Applicant(s)/Patent Under Reexamination WATANABE, NAOYA Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,917,489	06-1999	Thurlow et al.	709/206
	В	US-6,549,950	04-2003	Lytle et al.	709/206
	С	US-6,912,519	06-2005	Shouji, Takeshi	709/206
	D	US-			
	Ε	US-			
	F	US-			
	G	US-			
	Ξ	US-			
	_	US-			
	J	US-			
	К	US-		·	
	٦	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	×	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.